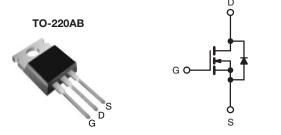


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	65	650				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.93				
Q <sub>g</sub> (Max.) (nC)	48	3				
Q <sub>gs</sub> (nC)	12	12				
Q <sub>gd</sub> (nC)	19					
Configuration	Single					



N-Channel MOSFET

#### **FEATURES**

• Low Gate Charge Qq Results in Simple Drive



• Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS Directive 2002/95/EC

### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

### **TYPICAL SMPS TOPOLOGIES**

- Single Transistor Flyback
- Single Transistor Forward

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRFB9N65APbF
	SiHFB9N65A-E3
SnPb	IRFB9N65A
	SiHFB9N65A

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	650	V	
Gate-Source Voltage			V <sub>GS</sub>	± 30	V	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	8.5		
Continuous Drain Current		T <sub>C</sub> = 100 °C		5.4	Α	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	21				
Linear Derating Factor				1.3	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	325	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	5.2	А	
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	16	mJ			
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			P <sub>D</sub>	167	W	
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	2.8	V/ns			
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150		
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>	°C	
Marie Tarre	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting  $T_J = 25$  °C, L = 24 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 5.2$  A (see fig. 12).
- c.  $I_{SD} \le 5.2$  A,  $dI/dt \le 90$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFB9N65A, SiHFB9N65A

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.75			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		·					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA <sup>d</sup>	-	670	-	mV/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> :	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$		$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	lean	V <sub>DS</sub> =	= 650 V, V <sub>GS</sub> = 0 V	-	-	25	μA
Zero Gate Voltage Drain Gurrent	I <sub>DSS</sub>	V <sub>DS</sub> = 520 \	V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 5.1 A <sup>b</sup>	1	-	0.93	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub>	= 50 V, I <sub>D</sub> = 3.1 A	3.9	-	-	S
Dynamic							
Input Capacitance	$C_{iss}$		$V_{GS} = 0 V$ ,	-	1417	-	
Output Capacitance	C <sub>oss</sub>	]	$V_{DS} = 25 V,$	-	177	-	]
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	7.0	-	] 
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$	1	1912	-	- pF -
		$V_{GS} = 0 V$	$V_{DS} = 520 \text{ V}, f = 1.0 \text{ MHz}$	-	48	-	
Effective Output Capacitance	Coss eff.		$V_{DS} = 0 \text{ V to } 520 \text{ V}^{c}$	1	84	-	
Total Gate Charge	$Q_g$				-	48	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 5.2 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 <sup>b</sup>	-	-	12	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	-	19	
Turn-On Delay Time	t <sub>d(on)</sub>				14	-	
Rise Time	t <sub>r</sub>		= 325 V, I <sub>D</sub> = 5.2 A	-	20	-	-
Turn-Off Delay Time	t <sub>d(off)</sub>	$=$ $H_g =$	$R_g = 9.1 \ \Omega, R_D = 62 \ \Omega,$ see fig. $10^b$		34	-	ns -
Fall Time	t <sub>f</sub>	g		-	18	-	
Drain-Source Body Diode Characteristic	cs	<u> </u>					
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.2	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	21	- A
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = 5.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 5.2 A, dl/dt = 100 A/µs <sup>b</sup>		-	493	739	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	2.1	3.2	μC
Forward Turn-On Time	t <sub>on</sub>	1 - 1 - 2 2 - 1	n-on is dominated by L <sub>S</sub> and L <sub>D</sub> )			1 \	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .
- d. Uses SiHFIB5N65A data and test conditions.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

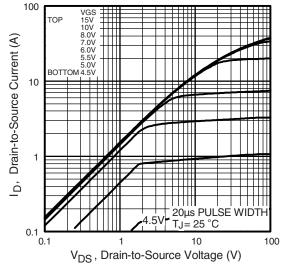


Fig. 1 - Typical Output Characteristics

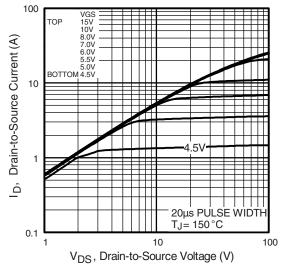


Fig. 2 - Typical Output Characteristics

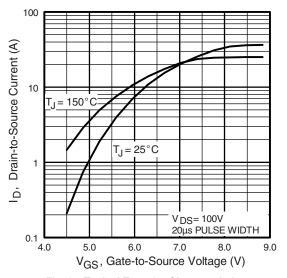


Fig. 3 - Typical Transfer Characteristics

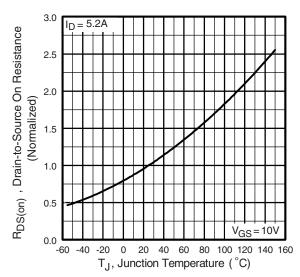


Fig. 4 - Normalized On-Resistance vs. Temperature

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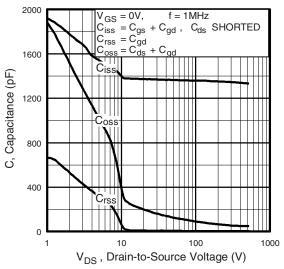


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

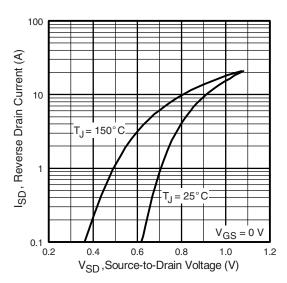


Fig. 7 - Typical Source-Drain Diode Forward Voltage

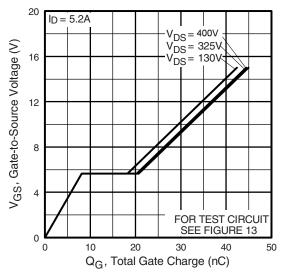


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

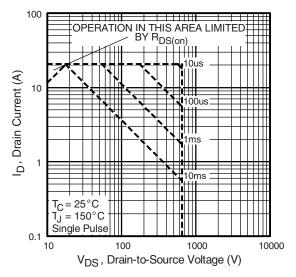


Fig. 8 - Maximum Safe Operating Area



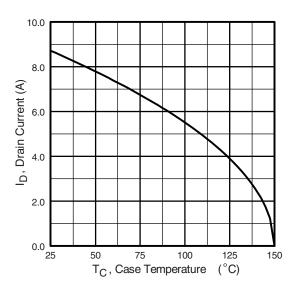


Fig. 9 - Maximum Drain Current vs. Case Temperature

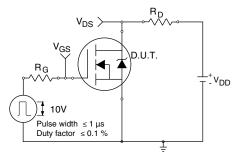


Fig. 10a - Switching Time Test Circuit

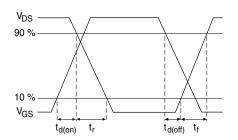


Fig. 10b - Switching Time Waveforms

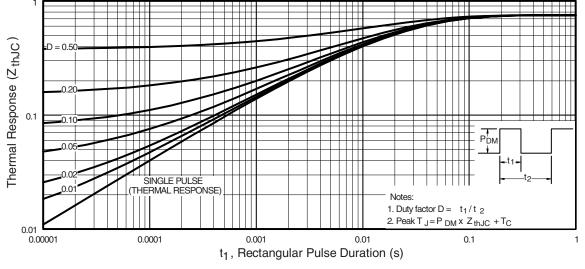


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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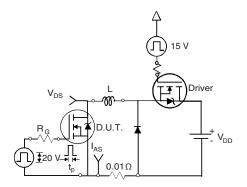


Fig. 12a - Unclamped Inductive Test Circuit

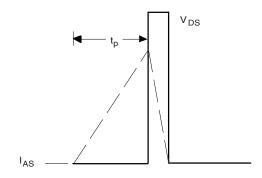


Fig. 12b - Unclamped Inductive Waveforms

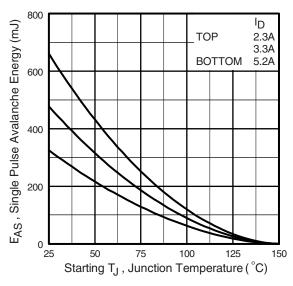


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

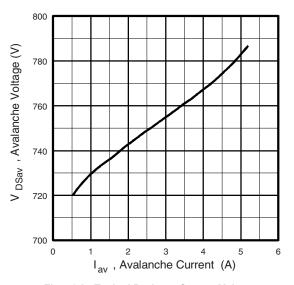


Fig. 12d - Typical Drain-to-Source Voltage vs.
Avalanche Current

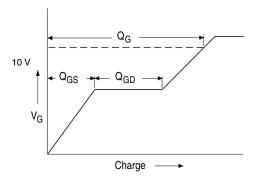


Fig. 13a - Basic Gate Charge Waveform

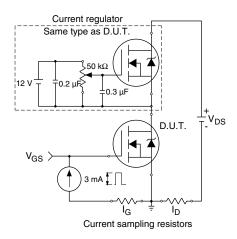
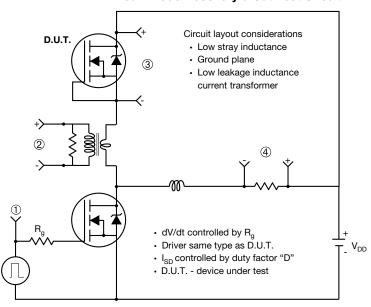


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



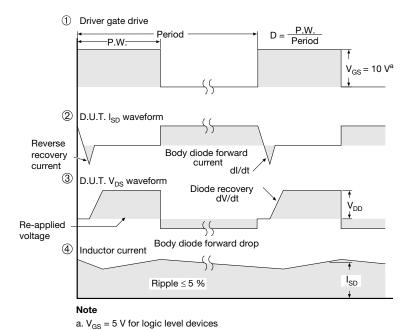


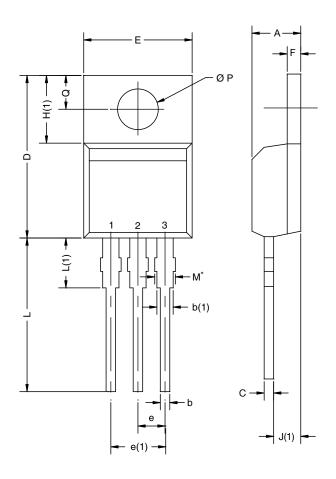
Fig. 14 - For N-Channel

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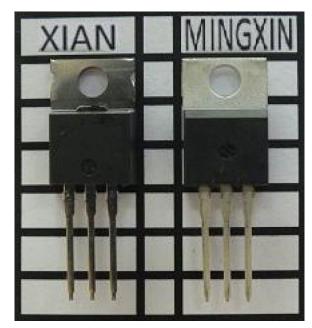
### **TO-220AB**



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
E	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471						

#### **Notes**

- $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM
- Xi'an and Mingxin actual photo





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